

<b>Notice of References Cited</b>	Application/Control No. 09/901,402	Applicant(s)/Patent Under Reexamination HSIEH ET AL.	
	Examiner Ricardo Pizarro	Art Unit 2661	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,259,700	07-2001	Hsieh et al.	370/400
*	B	US-5,964,831	10-1999	Kearns et al.	709/201
*	C	US-6,907,401	06-2005	Vittal et al.	705/26
*	D	US-6,125,352	09-2000	Franklin et al.	705/26
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages)
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